

Searching PAJ

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Text Search If you want to conduct a Number Search, please click on the button to the right. Number Search

Applicant, Title of invention, Abstract — e.g. computer semiconductor

If you use the AND/OR operation, please leave a SPACE between keywords.
One letter word or Stopwords are not searchable.

piezoelectric transformer

AND

AND

manufacturing testing

AND

AND

AND

AND

Date of publication of application — e.g. 19980401 - 19980405

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AND

IPC — e.g. D01B7/04 A01C11/02

If you use the OR operation, please leave a SPACE between keywords.



Search Stored data

	Type	L #	Hits	Search Text	DBs	Time Stamp	Comments
1	BRS	L1	15	part same testing.ti.	USPAT	2004/08/30 12:34	
2	BRS	L2	9	(manufacturing adj2 method and testing).ti.	USPAT	2004/08/30 12:36	
3	BRS	L3	165	testing adj1 during adj1 manufactur\$3	USPAT	2004/08/30 12:38	
4	BRS	L4	0	l3 and piezoelectric adj1 transformer\$	USPAT	2004/08/30 12:38	
5	BRS	L5	13	l3 and (electric or electronic) adj1 component\$1	USPAT	2004/08/30 12:40	
6	BRS	L6	64	piezoelectric adj1 transformer and test\$3	USPAT	2004/08/30 12:48	
7	BRS	L7	45	l6 and manufactur\$	USPAT	2004/08/30 12:47	
8	BRS	L8	8	l6 and manufactur\$ adj2 process\$3	USPAT	2004/08/30 12:47	
9	BRS	L9	8	piezoelectric adj1 transformer and manufactur\$3 same test\$3	USPAT	2004/08/30 13:22	
10	BRS	L10	30	piezoelectric adj1 transformer and manufactur\$3 same test\$3	US-PGPUB; EPO; JPO; DERWENT; IBM-TDB	2004/08/30 13:23	